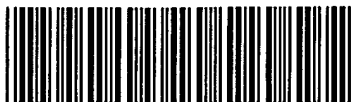


Search Notes



Application/Control No.

10/615,050

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

EILERT, SEAN E.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	132	9/3/05	HT
	219	↓	↓
(Both - Text search only - see EAST search) Print out			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search. hit is attached.	9/3/05	HT
NPL search using terms similar to EAST search.	↓	↓
Inventorship search.		